TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (L^2 - π -MOSVI)

TPC8302

Lithium Ion Battery Applications
Portable Equipment Applications
Notebook PCs

- 2.5 V Gate drive
- Small footprint due to small and thin package
- Low drain-source ON resistance: RDS (ON) = 100 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 5 S$ (typ.)
- Low leakage current: $IDSS = -10 \mu A (max) (VDS = -20 V)$
- Enhancement–mode: V_{th} = -0.5~ -1.1 V (V_{DS} = -10 V, I_{D} = -200 μA)

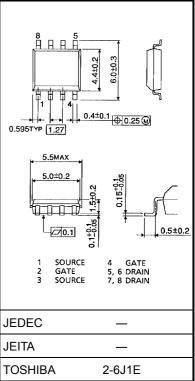
Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vo	Itage	V_{DSS}	-20	V	
Drain-gate volta	ge (R _{GS} = 20 kΩ)	V_{DGR}	-20	V	
Gate-source vol	tage	V_{GSS}	±12	V	
Drain current	D C (Note 1)	I _D	-3.5	Α	
Diaili cuiteit	Pulse (Note 1)	I_{DP}	-20 -20 ±12 -3.5 -14 1.5 1.0 0.75 0.45 16 -3.5 0.1	^	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	1.5		
(t = 10s) (Note 2a)	Single-devece value at dual operation (Note 3b)	P _{D (2)}	1.0	W	
Drain power dissipation (t = 10s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.75	W	
	Single-devece value at dual operation (Note 3b)	P _{D 2)}	0.45		
Single pulse ava	lanche energy (Note 4)	E _{AS}	16	mJ	
Avalanche curre	nt	I _{AR}	-3.5	Α	
Repetitive avalar (Note	nche energy e 2a, Note 3b, Note 5)	E _{AR}	0.1	mJ	
Channel tempera	ature	T _{ch}	150	°C	
Storage tempera	ture range	T _{stg}	-55~150	°C	

Note: For (Note 1), (Note 2a), (Note 2b), (Note 3a), (Note 3b), (Note 4) and (Note 5), please refer to the next page.

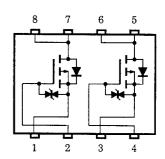
This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm



Weight: 0.080 g (typ.)

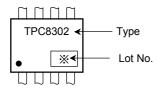
Circuit Configuration



Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3	°C/W	
	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	125		
Thermal resistance, channel to ambient	Single-device operation (Note 2a)	R _{th (ch-a) (1)}	167	C/VV	
(t = 10s) (Note 2	Single-device value at dual operation (Note 2b)	R _{th (ch-a) (2)}	278		

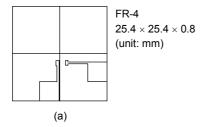
Marking

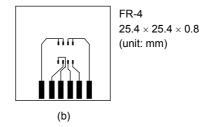


Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a)
- b) Device mounted on a glass-epoxy board (b)





Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.)

Note 4:

$$V_{DD}$$
 = -16 V, T_{ch} = 25°C (Initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = -3.5 A

Note 5: Repetitive rating: pulse width limited by maximum channel temperature

Note 6: • on lower left of the marking indicates Pin 1.



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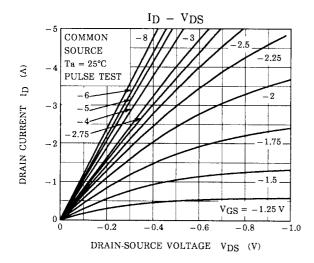
Electrical Characteristics (Ta = 25°C)

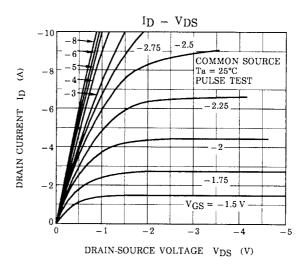
Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±10 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-OFF	current	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V	_	_	-10	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-20	_	_	V
Gate threshold v	oltage	V _{th}	V _{DS} = -10 V, I _D = -200 μA	-0.5	_	-1.1	V
Drain aguras O	N reciptores	R _{DS (ON)}	V _{GS} = -2.5 V, I _D = -1.8 A	_	135	170	0
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = -4 V, I _D = -1.8 A	_	100	120	mΩ
Forward transfer admittance		Y _{fs}	V _{DS} = -10 V, I _D = -1.8 A	2.5	5	_	S
Input capacitano	е	C _{iss}		_	680	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	90	_	pF
Output capacitance		C _{oss}		_	310	_	
Switching time	Rise time	t _r	$V_{GS} = \frac{0 \text{ V}}{5 \text{ V}}$ $V_{GS} = \frac{10}{5.6} \text{ M}$ $V_{DD} = -10 \text{ V}$ $V_{DU} = 10 \mu\text{s}$	_	17	_	
	Turn-ON time	t _{on}		_	24	_	ns
	Fall time	t _f		_	20	_	
	Turn-OFF time	t _{off}		-	63	_	
Total gate charge (Gate-source plus gate-drain)		Qg	$V_{DD} \approx -16 \text{ V}, V_{GS} = -5 \text{ V}, I_D = -3.5 \text{ A}$		16		
Gate-source charge		Q _{gs}			10	_	nC
Gate-drain ("miller") charge		Q_{gd}		_	6	_	

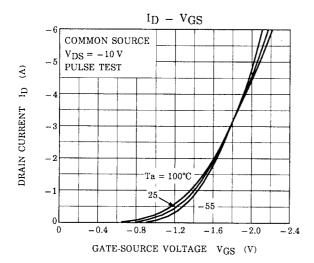
Source-Drain Ratings and Characteristics (Ta = 25°C)

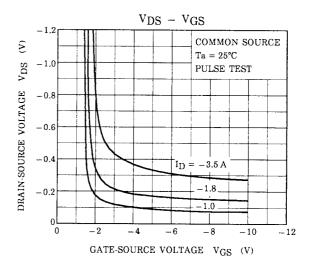
Charact	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}		_	-	-14	Α
Forward voltage ((diode)	V _{DSF}	$I_{DR} = -3.5 \text{ A}, V_{GS} = 0 \text{ V}$		_	1.2	V

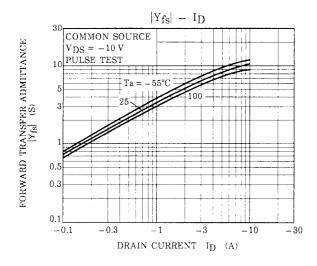
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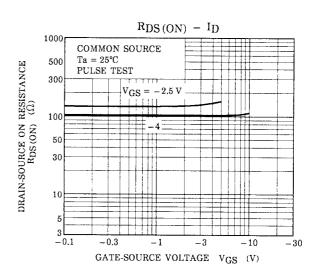




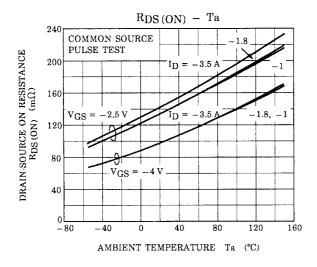


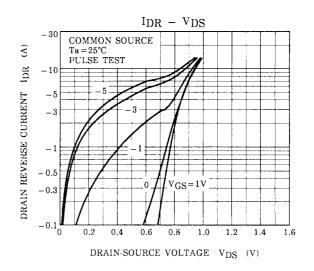


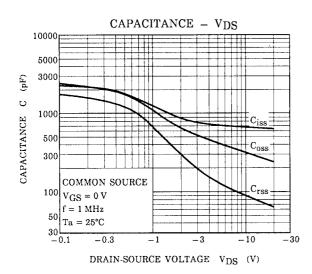


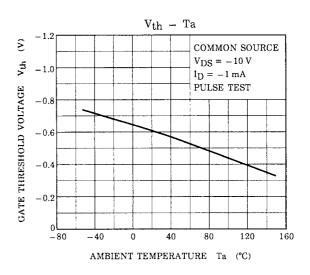


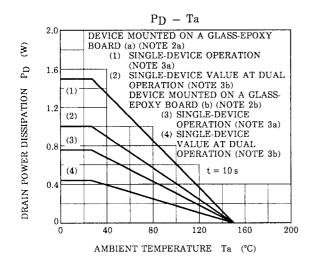
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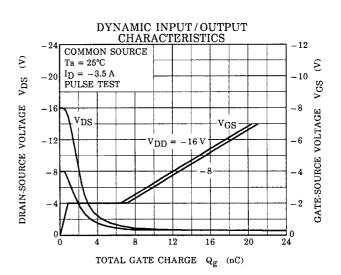






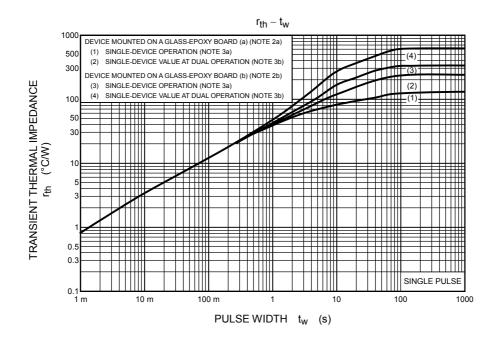


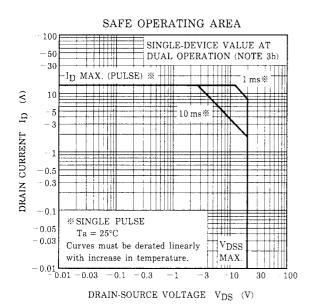


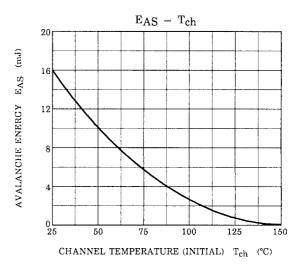


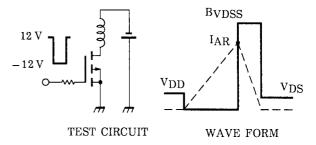
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$$\begin{array}{l} T_{ch} = 25^{\circ}C \ (Initial) \\ Peak \ I_{AR} = -3.5 \ A, \ R_G = 25 \ \Omega \\ V_{DD} = -16 \ V, \ L = 1.0 \ mH \end{array} \\ \begin{array}{l} E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot (\ \frac{BVDSS}{BVDSS - V_{DD}}) \end{array}$$

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